



**Product data sheet** 

## 1. Product profile

### 1.1 General description

Silicon Monolithic Microwave Integrated Circuit (MMIC) wideband amplifier with internal matching circuit in a 6-pin SOT363 plastic SMD package.

### 1.2 Features and benefits

- Internally matched to 50 Ω
- A gain of 24.4 dB at 2150 MHz
- Output power at 1 dB gain compression = 5 dBm at 2150 MHz
- Supply current = 20.0 mA at a supply voltage of 3.3 V
- Reverse isolation > 39 dB up to 2150 MHz
- Good linearity with low second order and third order products
- Noise figure = 3.9 dB at 950 MHz
- Unconditionally stable (K > 1)
- No output inductor required

### 1.3 Applications

- LNB IF amplifiers
- General purpose low noise wideband amplifier for frequencies between DC and 2.2 GHz

## 2. Pinning information

Pin	Description	Simplified outline	Graphic symbol
1	V <sub>CC</sub>		
2, 5	GND2		
3	RF_OUT		
4	GND1		
6	RF_IN		4 2, 5 777 777 sym052



## 3. Ordering information

Table 2. Orde	ring informa	ition	
Type number	Package		
	Name	Description	Version
BGA2817	-	plastic surface-mounted package; 6 leads	SOT363

## 4. Marking

Table 3. Marking						
Type number	Marking code	Description				
BGA2817	LS*	* = - : made in Hong Kong				
		* = p : made in Hong Kong				
		* = W : made in China				
		* = t : made in Malaysia				

## 5. Limiting values

### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage	RF input AC coupled	-0.5	+5.0	V
I <sub>CC</sub>	supply current		-	55	mA
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> = 90 °C	-	200	mW
T <sub>stg</sub>	storage temperature		-40	+125	°C
Tj	junction temperature		-	125	°C
P <sub>drive</sub>	drive power		-	10	dBm

## 6. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Тур	Unit		
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point	$P_{tot} = 200 \text{ mW}; T_{sp} = 90 ^{\circ}\text{C}$	300	K/W		

## 7. Characteristics

### Table 6.Characteristics

 $V_{CC} = 3.3 V; Z_S = Z_L = 50 \Omega; P_i = -40 \text{ dBm}; T_{amb} = 25 \text{ °C}; \text{ measured on demo board; unless otherwise specified.}$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		3.0	3.3	3.6	V
I <sub>CC</sub>	supply current		17.6	20.0	22.2	mA

BGA2817

### Table 6. Characteristics ... continued

 $V_{CC} = 3.3 V; Z_S = Z_L = 50 \Omega; P_i = -40 \text{ dBm}; T_{amb} = 25 \text{ °C}; \text{ measured on demo board; unless otherwise specified.}$ 

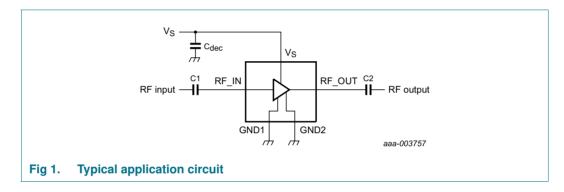
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
G <sub>p</sub>	power gain	f = 250 MHz	23.6	24.2	24.8	dB
		f = 950 MHz	23.5	24.3	25	dB
		f = 2150 MHz	23	24.4	25.9	dB
RL <sub>in</sub>	input return loss	f = 250 MHz	13	15	-	dB
		f = 950 MHz	16	18	-	dB
		f = 2150 MHz	13	20	-	dB
RLout	output return loss	f = 250 MHz	12	17	-	dB
		f = 950 MHz	16	17	-	dB
		f = 2150 MHz	17	20	-	dB
ISL	isolation	f = 250 MHz	36	57	-	dB
		f = 950 MHz	47	49	-	dB
		f = 2150 MHz	37	39	-	dB
NF	noise figure	f = 250 MHz	-	3.9	4.4	dB
		f = 950 MHz	-	3.9	4.3	dB
		f = 2150 MHz	-	3.8	4.2	dB
B <sub>-3dB</sub>	–3 dB bandwidth	3 dB below gain at 1 GHz	3.3	3.5	3.7	GHz
К	Rollett stability factor	f = 250 MHz	10	21	-	
		f = 950 MHz	7	9	-	
		f = 2150 MHz	1.5	2.7	-	
P <sub>L(sat)</sub>	saturated output power	f = 250 MHz	8	8	-	dBm
		f = 950 MHz	5	7	-	dBm
		f = 2150 MHz	5	6	-	dBm
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	f = 250 MHz	6	6	-	dBm
		f = 950 MHz	5	6	-	dBm
		f = 2150 MHz	4	5	-	dBm
IP3 <sub>I</sub>	input third-order intercept point	$P_{drive} = -40 \text{ dBm}$ (for each tone)				
		f <sub>1</sub> = 250 MHz; f <sub>2</sub> = 251 MHz	-9	-7	-	dBm
		f <sub>1</sub> = 950 MHz; f <sub>2</sub> = 951 MHz	-9	-7	-	dBm
		f <sub>1</sub> = 2150 MHz; f <sub>2</sub> = 2151 MHz	-13	-10	-	dBm
IP3 <sub>0</sub>	output third-order intercept point	$P_{drive} = -40 \text{ dBm}$ (for each tone)				
		f <sub>1</sub> = 250 MHz; f <sub>2</sub> = 251 MHz	16	18	-	dBm
		f <sub>1</sub> = 950 MHz; f <sub>2</sub> = 951 MHz	16	18	-	dBm
		f <sub>1</sub> = 2150 MHz; f <sub>2</sub> = 2151 MHz	12.5	15.5	-	dBm
P <sub>L(2H)</sub>	second harmonic output power	P <sub>drive</sub> = −28 dBm				-
. /		f <sub>1H</sub> = 250 MHz; f <sub>2H</sub> = 500 MHz	-	-53	-51	dBm
		f <sub>1H</sub> = 950 MHz; f <sub>2H</sub> = 1900 MHz	-	-45	-41	dBm
∆IM2	second-order intermodulation distance	$P_{drive} = -31 \text{ dBm}$ (for each tone)				
		$f_1 = 250 \text{ MHz}; f_2 = 251 \text{ MHz}$	34	36	-	dBc
		f <sub>1</sub> = 950 MHz; f <sub>2</sub> = 951 MHz	33	39	-	dBc

## 8. Application information

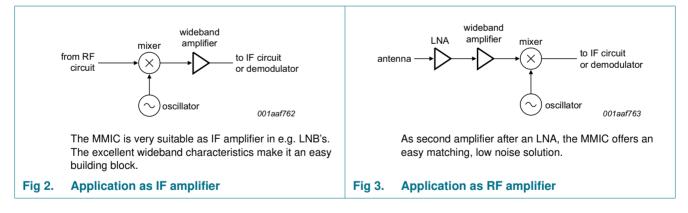
Figure 1 shows a typical application circuit for the BGA2817 MMIC. The device is internally matched to 50  $\Omega$ , and therefore does not need any external matching. The value of the input and output DC blocking capacitors C2 and C3 should not be more than 100 pF for applications above 100 MHz. However, when the device is operated below 100 MHz, the capacitor value should be increased.

The location of the 470 pF supply decoupling capacitor ( $C_{dec}$ ) can be precisely chosen for optimum performance.

The PCB top ground plane, connected to pins 2, 4 and 5 must be as close as possible to the MMIC, preferably also below the MMIC. When using via holes, use multiple via holes as close as possible to the MMIC.



### 8.1 Application examples



### 8.2 Tables

# Table 7.Supply current over temperature and supply voltagesTypical values.

Symbol	Parameter	Conditions	T <sub>amb</sub> (°C)		s T <sub>amb</sub> (°C)			Unit	
			-40	+25	+85				
I <sub>CC</sub>	supply current	$V_{CC} = 3.0 V$	18.0	17.6	17.3	mA			
		$V_{CC} = 3.3 V$	20.4	20.0	19.6	mA			
		$V_{CC} = 3.6 V$	22.7	22.2	21.7	mA			

Symbol	Parameter	Conditions	T <sub>amb</sub> (°C)			Unit
			-40	+25	+85	
P <sub>L(2H)</sub>	second harmonic output power	f = 250 MHz; $P_{drive}$ = -28 dBm				
		V <sub>CC</sub> = 3.0 V	-38	-44	-52	dBm
		V <sub>CC</sub> = 3.3 V	-45	-53	-60	dBm
		V <sub>CC</sub> = 3.6 V	-56	-59	-53	dBm
		f = 950 MHz; P <sub>drive</sub> = -28 dBm				
		V <sub>CC</sub> = 3.0 V	-43	-53	-45	dBm
		V <sub>CC</sub> = 3.3 V	-51	-45	-41	dBm
		V <sub>CC</sub> = 3.6 V	-44	-41	-39	dBm

# Table 8. Second harmonic output power over temperature and supply voltages Typical values. Second harmonic output power over temperature and supply voltages

# Table 9. Input power at 1 dB gain compression over temperature and supply voltages Typical values. Imput power at 1 dB gain compression over temperature and supply voltages

Symbol	Parameter	Conditions	T <sub>amb</sub>	(°C)		Unit
			-40	+25	+85	
P <sub>i(1dB)</sub>	input power at 1 dB gain compression	f = 250 MHz				
		$V_{CC} = 3.0 V$	-19	-18	-18	dBm
		V <sub>CC</sub> = 3.3 V	-17	-17	-17	dBm
		V <sub>CC</sub> = 3.6 V	-16	-16	-16	dBm
		f = 950 MHz				
		V <sub>CC</sub> = 3.0 V	-19	-18	-18	dBm
		$V_{CC} = 3.3 V$	-18	-17	-17	dBm
		$V_{CC} = 3.6 V$	-17	-17	-17	dBm
		f = 2150 MHz				
		$V_{CC} = 3.0 V$	-20	-20	-20	dBm
		V <sub>CC</sub> = 3.3 V	-19	-19	-20	dBm
		V <sub>CC</sub> = 3.6 V	-18	-19	-20	dBm

Symbol	Parameter	Conditions	Tamb	(°C)		Unit
			-40	+25	+85	
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	f = 250 MHz				
		$V_{\rm CC} = 3.0 \ V$	4	5	5	dBm
		$V_{CC} = 3.3 V$	6	6	6	dBm
		$V_{CC} = 3.6 V$	8	8	7	dBm
		f = 950 MHz				
		$V_{CC} = 3.0 V$	4	4	4	dBm
		V <sub>CC</sub> = 3.3 V	6	6	6	dBm
		$V_{CC} = 3.6 V$	7	7	7	dBm
		f = 2150 MHz				
		$V_{CC} = 3.0 V$	4	4	3	dBm
		V <sub>CC</sub> = 3.3 V	6	5	4	dBm
		V <sub>CC</sub> = 3.6 V	7	6	5	dBm

 Table 10.
 Output power at 1 dB gain compression over temperature and supply voltages

 Typical values.
 Values.

# Table 11. Saturated output power over temperature and supply voltages Typical values. Values.

Symbol	Parameter	Conditions	T <sub>amb</sub>	<sub>թ</sub> (°C)		Unit
			-40	+25	+85	
P <sub>L(sat)</sub>	saturated output power	f = 250 MHz				
		V <sub>CC</sub> = 3.0 V	6	6	7	dBm
		V <sub>CC</sub> = 3.3 V	8	8	8	dBm
		V <sub>CC</sub> = 3.6 V	9	9	9	dBm
		f = 950 MHz				
		V <sub>CC</sub> = 3.0 V	6	6	6	dBm
		V <sub>CC</sub> = 3.3 V	7	7	7	dBm
		V <sub>CC</sub> = 3.6 V	7	8	8	dBm
		f = 2150 MHz				
		V <sub>CC</sub> = 3.0 V	5	5	4	dBm
		V <sub>CC</sub> = 3.3 V	7	6	5	dBm
		V <sub>CC</sub> = 3.6 V	8	7	6	dBm

Symbol	Parameter	Conditions	Tamb	T <sub>amb</sub> (°C)		
			-40	+25	+85	
∆IM2 second-order intermodulation dista	second-order intermodulation distance					
		$V_{CC} = 3.0 V$	28	32	36	dBc
		V <sub>CC</sub> = 3.3 V	33	36	40	dBc
		V <sub>CC</sub> = 3.6 V	38	40	44	dBc
		$f_1 = 950 \text{ MHz};$ $f_2 = 951 \text{ MHz};$ $P_{drive} = -31 \text{ dBm}$				
		V <sub>CC</sub> = 3.0 V	29	34	40	dBc
		V <sub>CC</sub> = 3.3 V	35	39	43	dBc
		V <sub>CC</sub> = 3.6 V	40	44	42	dBc

# Table 12. Second-order intermodulation distance over temperature and supply voltages Typical values. Values.

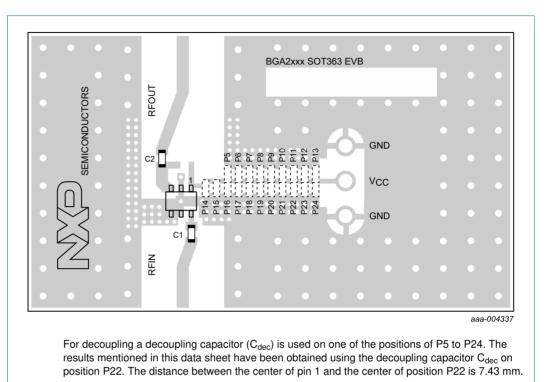
# Table 13. Output third-order intercept point over temperature and supply voltages Typical values. Values.

Symbol	Parameter	Conditions	Tamb	T <sub>amb</sub> (°C)		
			-40	+25	+85	
IP3 <sub>0</sub>	output third-order intercept point	$f_1 = 250 \text{ MHz};$ $f_2 = 251 \text{ MHz};$ $P_{drive} = -40 \text{ dBm}$				
		$V_{CC} = 3.0 V$	14	15	16	dBm
		V <sub>CC</sub> = 3.3 V	18	18	17	dBm
		V <sub>CC</sub> = 3.6 V	19	19	19	dBm
		$f_1 = 950 \text{ MHz};$ $f_2 = 951 \text{ MHz};$ $P_{drive} = -40 \text{ dBm}$				
		$V_{CC} = 3.0 V$	15	16	15	dBm
		$V_{CC} = 3.3 V$	18	18	17	dBm
		V <sub>CC</sub> = 3.6 V	20	20	18	dBm
		$f_1 = 2150 \text{ MHz};$ $f_2 = 2151 \text{ MHz};$ $P_{drive} = -40 \text{ dBm}$				
		$V_{CC} = 3.0 V$	15.5	14.5	12.5	dBm
		V <sub>CC</sub> = 3.3 V	17.5	15.5	13.5	dBm
		V <sub>CC</sub> = 3.6 V	18.5	16.5	13.5	dBm

#### 

Symbol	Parameter	Conditions	T <sub>amb</sub> (°C)			Unit
			-40	+25	+85	
B <sub>-3dB</sub>	-3 dB bandwidth	$V_{CC} = 3.0 V$	3.6	3.49	3.34	GHz
		$V_{CC} = 3.3 V$	3.59	3.47	3.32	GHz
		$V_{CC} = 3.6 V$	3.58	3.46	3.31	GHz

## 9. Test information



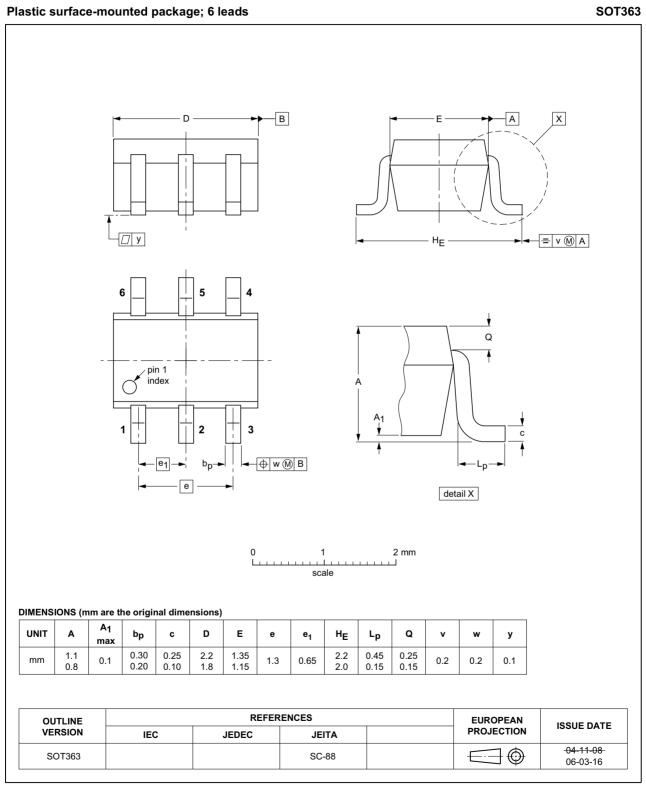
### Fig 4. PCB layout and demo board with components

#### Table 15. List of components used for the typical application

Component	Description	Value	Dimensions	Remarks
C1, C2	multilayer ceramic chip capacitor	470 pF	0603	X7R RF coupling capacitor
P5 to P24 [1]	position for multilayer ceramic chip capacitor C <sub>dec</sub>	470 pF	0603	X7R RF decoupling capacitor
IC1	BGA2817 MMIC	-	SOT363	

[1] For decoupling a decoupling capacitor ( $C_{dec}$ ) is used on one of the positions of P5 to P24. The results mentioned in this data sheet have been obtained using the decoupling capacitor  $C_{dec}$  on position P22.

## **10. Package outline**



### Fig 5. Package outline SOT363

BGA2817

**Product data sheet** 

# **11. Abbreviations**

Table 16. Abbreviations				
Acronym	Description			
IF	Intermediate Frequency			
LNA	Low-Noise Amplifier			
LNB	Low-Noise Block converter			
PCB	Printed-Circuit Board			
SMD	Surface Mounted Device			

# **12. Revision history**

### Table 17. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BGA2817 v.7	20170330	Product data sheet	-	BGA2817 v.6
Modifications:	• <u>Table 6 on page</u> to -41 dBm	2: the maximum value for t	1H = 950 MHz; f2H = 1	900 MHz has been changed
	<u>Table 6 on page</u> changed to 33 c	2: the minimum value for a IBc	∆IM2 (f1 = 950 MHz; f2	= 951 MHz) has been
	<ul> <li>Table 6 on page IP3<sub>O</sub>, ∆IM2</li> </ul>	2: the maximum value ren	noved from $RL_{in}$ , $RL_{out}$ ,	$ISL,K,P_{L(sat)},P_{L(1dB)},IP3_{I},$
	Table 6 on page	2: the minimum value rem	oved from NF, $P_{L(2H)}$	
BGA2817 v.6	20161003	Product data sheet	-	BGA2817 v.5
Modifications:	Table 6 on page	2: the min/max value for P	P <sub>L(2H)</sub> (f <sub>1H</sub> = 950 MHz; f <sub>2</sub>	<sub>H</sub> = 1900 MHz) removed
	Table 6 on page	2: the min/max value for $\Delta$	IM2 (f <sub>1</sub> = 950 MHz; f <sub>2</sub> =	951 MHz) removed
BGA2817 v.5	20150330	Product data sheet	-	BGA2817 v.4
Modifications:	Table 4 on page	2: the maximum value for	P <sub>drive</sub> has been change	d to 10 dBm
BGA2817 v.4	20141203	Product data sheet	-	BGA2817 v.3
BGA2817 v.3	20130826	Product data sheet	-	BGA2817 v.2
BGA2817 v.2	20120419	Product data sheet	-	BGA2817 v.1
BGA2817 v.1	20111117	Product data sheet	-	-

# 13. Legal information

### 13.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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